

<b>Notice of References Cited</b>	Application/Control No. 10/597,002		Applicant(s)/Patent Under Reexamination VAVIK, GEIR MONSEN	
	Examiner Stephen M. D'Agosta		Art Unit 2617	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0242185	12-2004	Lee, Jack Wing	455/402
*	B	US-6,253,060	06-2001	Komara et al.	455/9
*	C	US-4,882,765	11-1989	Maxwell et al.	455/18
*	D	US-5,408,679	04-1995	Masuda, Hajime	455/11.1
*	E	US-6,941,576	09-2005	Amit, Mati	725/143
*	F	US-2002/0075806	06-2002	Shalvi et al.	370/235
*	G	US-5,295,154	03-1994	Meier et al.	370/351
*	H	US-2005/0020233	01-2005	Cern, Yehuda	455/402
*	I	US-4,879,755	11-1989	Stolarczyk et al.	725/41
*	J	US-6,507,573	01-2003	Brandt et al.	370/335
*	K	US-6,285,857	09-2001	Javitt, Joel I.	455/15
*	L	US-6,690,916	02-2004	Yenerim, Savas	455/11.1
*	M	US-2004/0110483	06-2004	Mollenkopf, James Douglas	455/402

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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